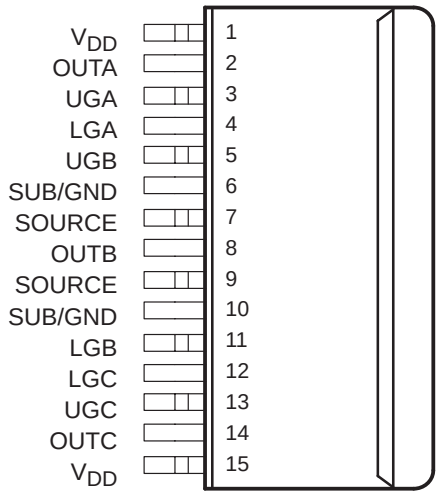
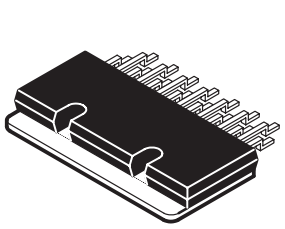
- **Configured for 3-Phase Brushless Motor Drive**
- **Low $r_{DS(on)}$ . . . 0.25 Ω Typ**
- **High Voltage Output . . . 30 V**
- **Pulsed Current . . . 12 A Per Channel**
- **Input Transient and ESD Protection**
- **Compatible With High-Side and Low-Side Current Sense Resistors**

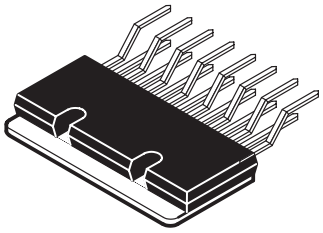
KTR or KTS PACKAGE
(TOP VIEW)



Tab is SUB/GND



KTR PACKAGE



KTS PACKAGE

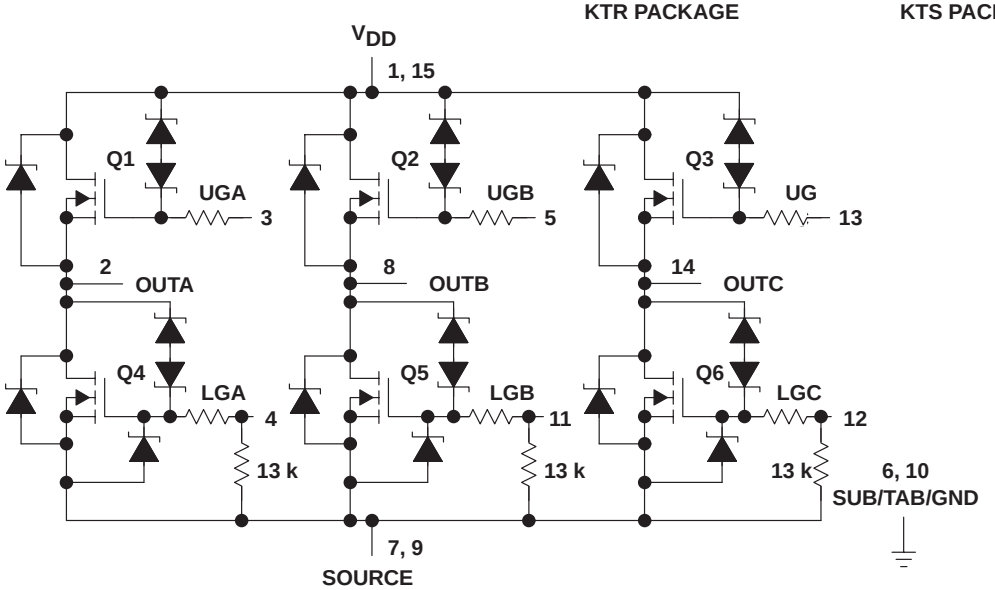
description

The TPIC1310 is a monolithic gate-protected power DMOS array that consists of six electrically isolated N-channel enhancement-mode DMOS transistors configured as a three-half H-bridge.

When suitably heat sunk, the TPIC1310 can drive motors requiring 2.5 A of phase current. The DMOS transistors are immune to second breakdown effects and current crowding, problems often associated with bipolar transistors.

The TPIC1310 is offered in 15-pin through-hole (KTS) and surface-mount (KTR) PowerFLEX™ packages and is characterized for operation over the case temperature range of –40°C to 125°C.

schematic



NOTES: A. Terminals 1 and 15 must be externally connected.
B. Terminals 6 and 10 must be connected to GND.
C. Terminals 7 and 9 must be connected to the sense resistor or GND.
D. No terminal may be taken greater than 0.5 V below GND.

absolute maximum ratings over operating case temperature range (unless otherwise noted)†

Drain-to-source voltage, V_{DS}	30 V
Output-to-GND voltage	30 V
SOURCE-to-SUB/GND voltage	–0.3 V to 20 V
Gate-to-source voltage range, V_{GS}	–0.3 V to 20 V
Continuous output current, each output, all outputs on, T_C = 25°C	3 A
Continuous source-to-drain diode current, T_C = 25°C	3 A
Pulsed output current, each output, I_{max}, T_C = 25°C (see Note 1 and Figure 14)	12 A
Continuous V_{DD} and SOURCE current, T_C = 25°C	3 A
Pulsed V_{DD} and SOURCE current, T_C = 25°C (see Note 1)	12 A
Continuous total dissipation, T_C = 25°C (see Note 2 and Figure 14)	13.9 W
Operating virtual junction temperature range, T_J	–40°C to 150°C
Operating case temperature range, T_C	–40°C to 125°C
Storage temperature range	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Pulse duration = 10 µs, duty cycle ≤ 2%
2. Package is mounted in intimate contact with an infinite heat sink.

electrical characteristics, T_C = 25°C (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage		I_D = 250 µA, V_{GS} = 0		30			V
$V_{GS(th)}$	Gate-to-source threshold voltage		I_D = 1 mA, V_{DS} = V_{GS}, See Figure 4		0.9	1.2	1.7	V
$V_{(BR)GS}$	Gate-to-source breakdown voltage	Low-side	I_{GS} = 250 µA		20			V
$V_{(BR)SG}$	Source-to-gate breakdown voltage	Low-side	I_{SG} = 250 µA		0.3			V
		High-side	I_{SG} = 250 µA		20			
$V_{DS(on)}$	Drain-to-source on-state voltage		I_D = 3 A, V_{GS} = 14 V, See Notes 3 and 4			0.66	0.9	V
$V_{F(SD)}$	Forward on-state voltage, source-to-drain		I_S = 3 A, V_{GS} = 0, See Notes 3 and 4 and Figure 11			1.1	1.4	V
I_{DSS}	Drain current-gate shorted to source		V_{DS} = 28 V, V_{GS} = 0	T_C = 25°C		0.05	1	µA
				T_C = 125°C		0.5	10	
I_{GSSF}	Forward-gate current, drain short circuited to source	Low-side	V_{SG} = 16 V, V_{DS} = 0, Internal 13 kΩ from gate to source			2	4	mA
		High-side	V_{SG} = 16 V, V_{DS} = 0			20	200	nA
I_{GSSR}	Reverse-gate current, drain short circuited to source		V_{SG} = 0.3 V, V_{DS} = 0			20	200	nA
I_{lkg}	Leakage current, drain-to-GND gate shorted to source		V_{DGND} = 28 V	T_C = 25°C		0.05	1	µA
				T_C = 125°C		0.5	10	
$r_{DS(on)}$	Static drain-to-source on-state resistance		V_{GS} = 10 V, I_D = 3 A, See Notes 3 and 4 and Figures 5 and 6	T_C = 25°C		0.27	0.37	Ω
				T_C = 125°C		0.45	0.55	
			V_{GS} = 14 V, I_D = 3 A, See Notes 3 and 4 and Figures 5 and 6	T_C = 25°C		0.22	0.32	
				T_C = 125°C		0.32	0.47	
g_{fs}	Forward transconductance		V_{DS} = 10 V, I_D = 3 A, See Notes 3 and 4 and Figure 8		0.5	0.85		S
C_{iss}	Short-circuit input capacitance, low-side		V_{DS} = 25 V, V_{GS} = 0, f = 1 MHz, See Figure 10			110		pF
C_{oss}	Short-circuit output capacitance, low-side					120		
C_{rss}	Short-circuit reverse transfer capacitance, low-side					60		

† Engineering estimate

NOTES: 3. Technique should limit $T_J - T_C$ to 10°C maximum.
4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

source-to-drain and GND-to-drain diode characteristics, T_C = 25°C

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{rr}	Reverse-recovery time	High-side	I_S = 3 A, V_{DS} = 28 V, V_{GS} = 0, di/dt = 100 A/µs, See Figures 1 and 13		30		ns
Q_{RR}	Total diode charge				30		nC
t_{rr}	Reverse-recovery time	Low-side	I_S = 3 A, V_{DS} = 28 V, V_{GS} = 0, di/dt = 100 A/µs, See Figure 13, SUB/GND connected to SOURCE		70		ns
Q_{RR}	Total diode charge				350		nC

resistive-load switching characteristics, T_C = 25°C

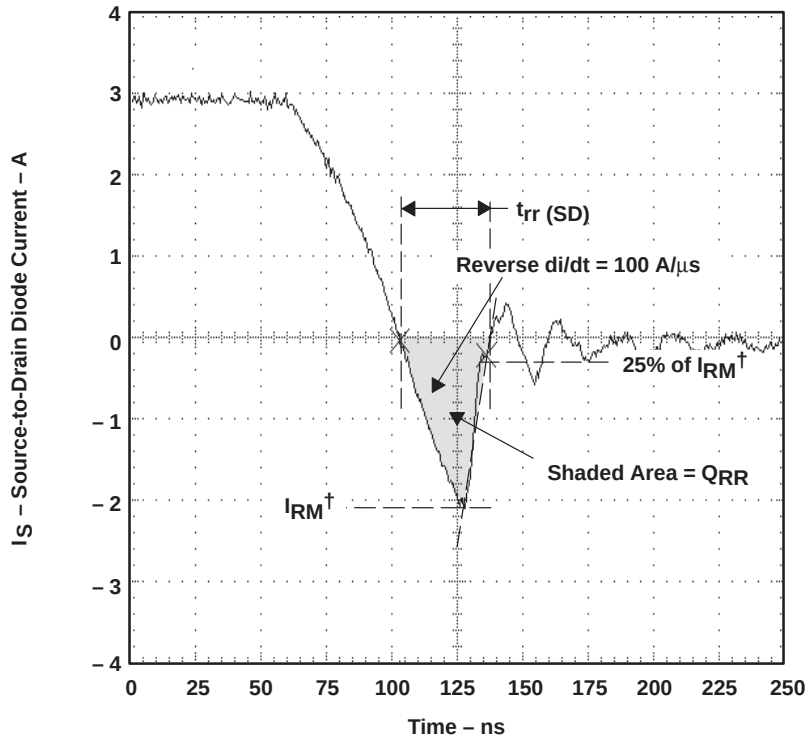
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{d(on)}$	Turn-on delay time	V_{DD} = 28 V, R_L = 9.3 Ω, t_{en} = 10 ns, t_{dis} = 10 ns, See Figure 2		70		ns
$t_{d(off)}$	Turn-off delay time			200		
t_r	Rise time			140		
t_f	Fall time			55		
Q_g	Total gate charge	V_{DS} = 12 V, I_D = 3 A, V_{GS} = 10 V, See Figure 3 and Figure 12		1.6	2	nC
$Q_{gs(th)}$	Threshold gate-to-source charge			0.5	0.62	
Q_{gd}	Gate-to-drain charge			0.25	0.31	
L_D	Internal drain inductance			5		nH
L_S	Internal source inductance			5		
R_g	Internal gate resistance			500		Ω

thermal resistance

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance, one output on	See Note 5		7.5	9	°C/W
$R_{\theta JC}$	Junction-to-case thermal resistance, two outputs on	See Notes 5 and 6		4.5	5.5	°C/W

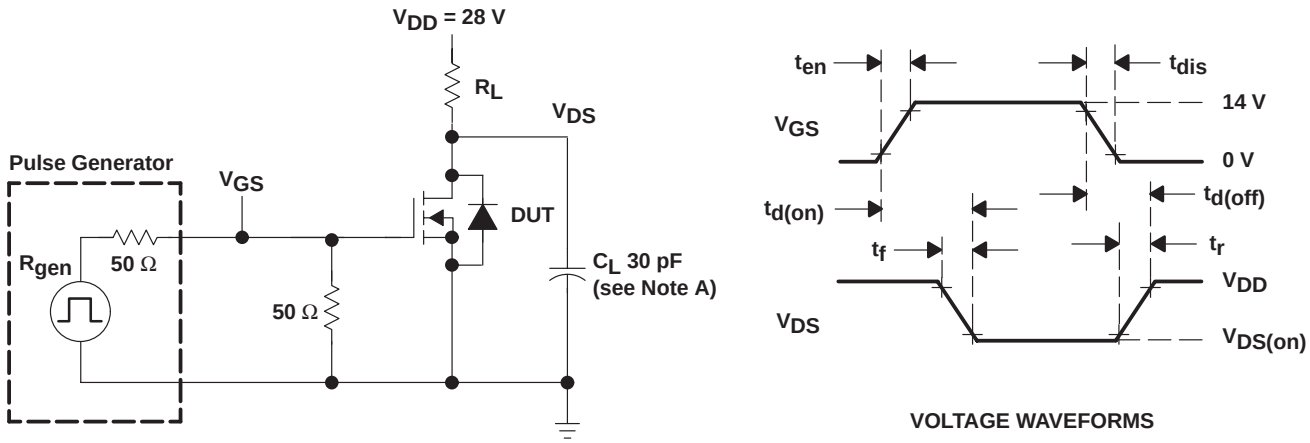
NOTES: 5. Package mounted in intimate contact with infinite heatsink.
6. Two outputs with equal power

PARAMETER MEASUREMENT INFORMATION



† I_{RM} = maximum recovery current

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diode



NOTE A: C_L includes probe and jig capacitance.

Figure 2. Resistive-Switching Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

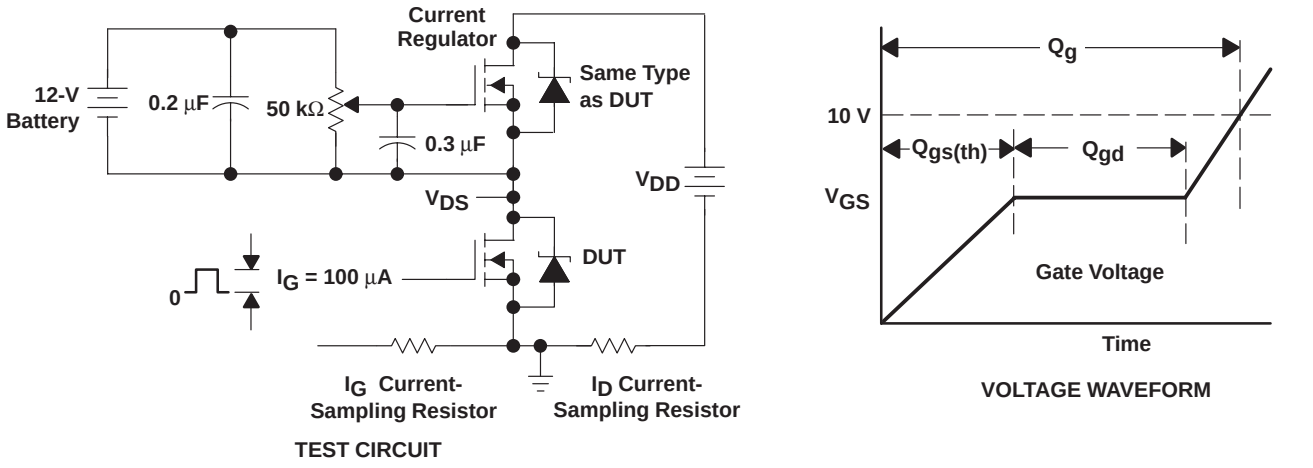


Figure 3. Gate-Charge Test Circuit and Voltage Waveform

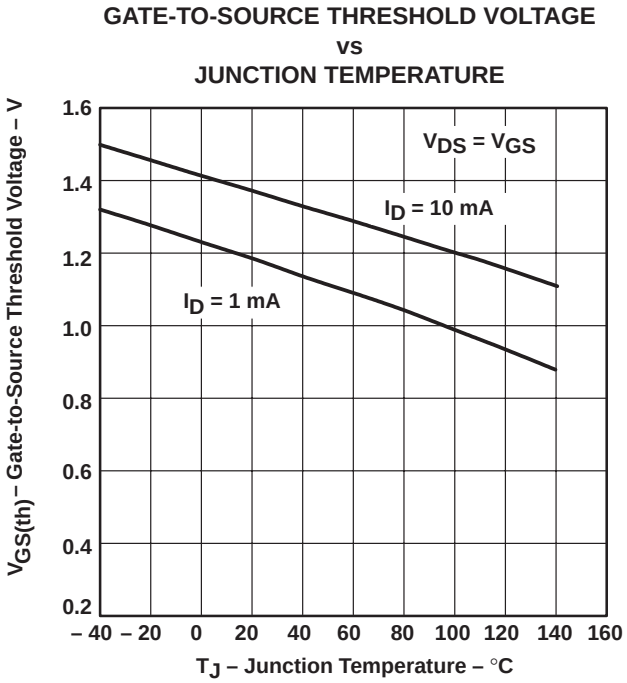


Figure 4

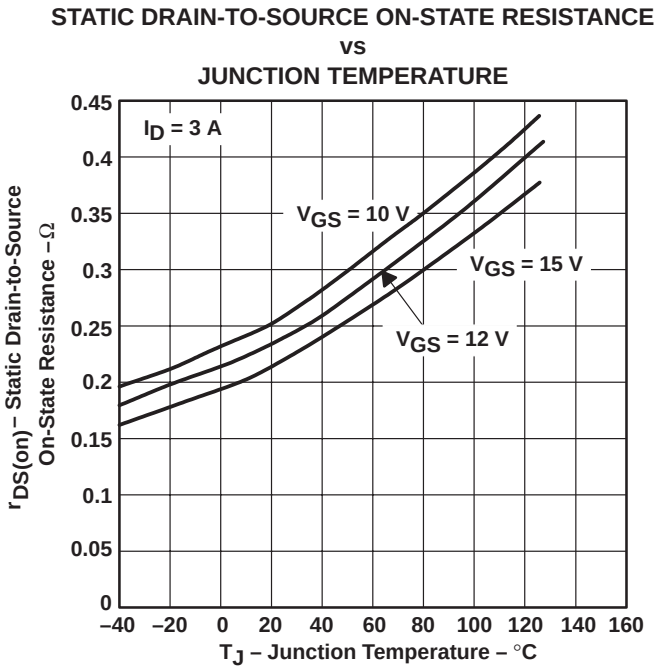


Figure 5

TYPICAL CHARACTERISTICS

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE vs DRAIN CURRENT

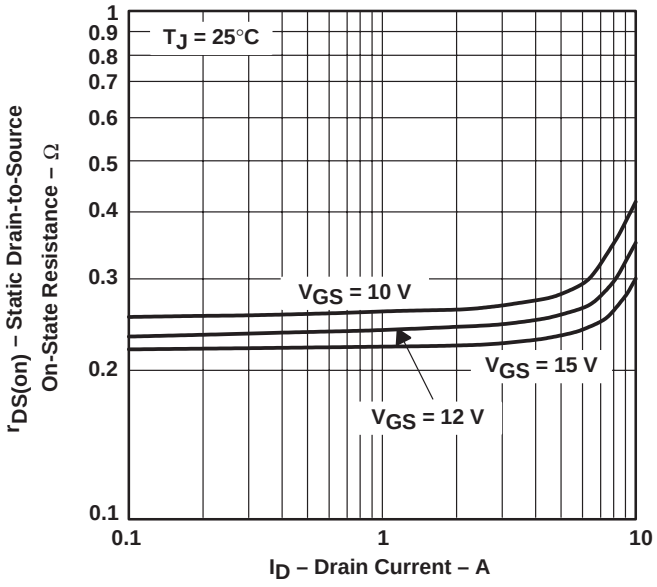


Figure 6

DRAIN CURRENT vs DRAIN-TO-SOURCE VOLTAGE

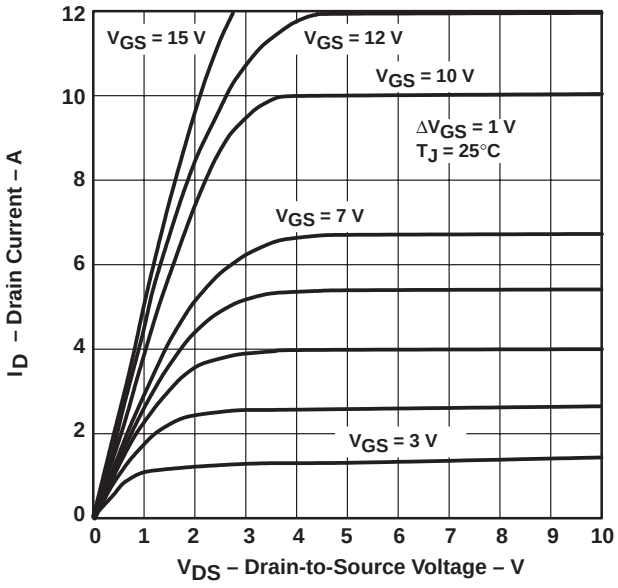


Figure 7

DISTRIBUTION OF FORWARD TRANSCONDUCTANCE

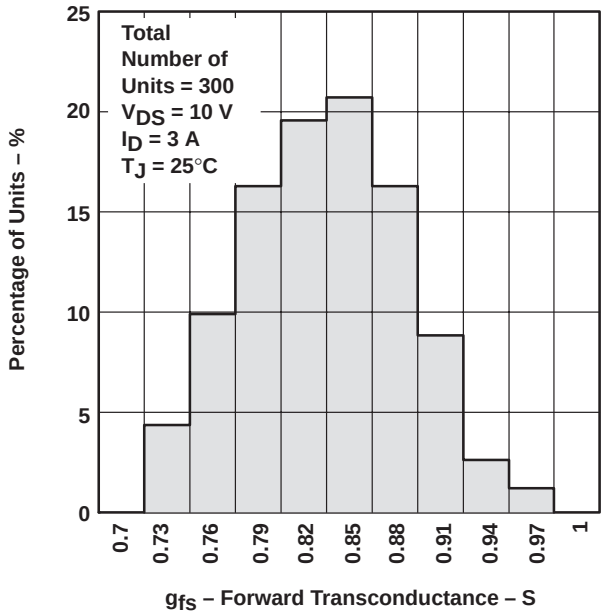


Figure 8

DRAIN CURRENT vs GATE-TO-SOURCE VOLTAGE (FOR LOW SIDE)

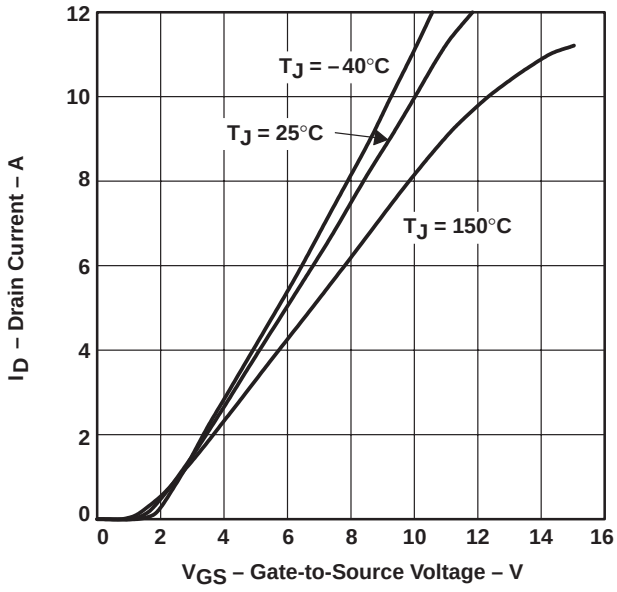


Figure 9

TYPICAL CHARACTERISTICS

CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE

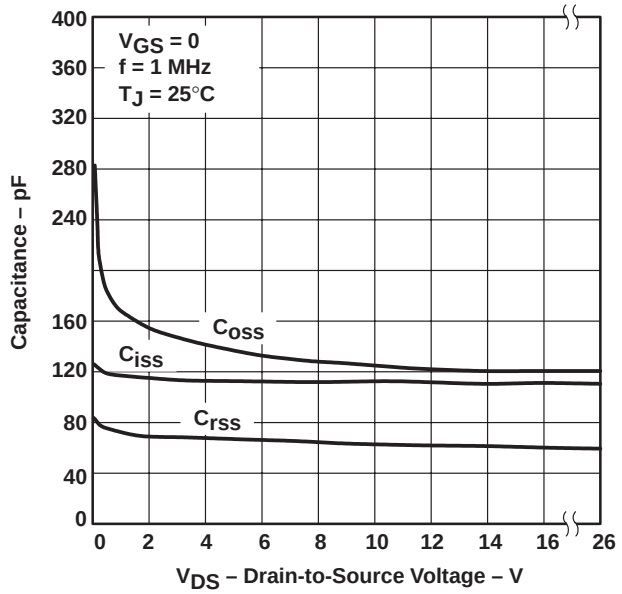


Figure 10

SOURCE-TO-DRAIN DIODE CURRENT vs SOURCE-TO-DRAIN VOLTAGE

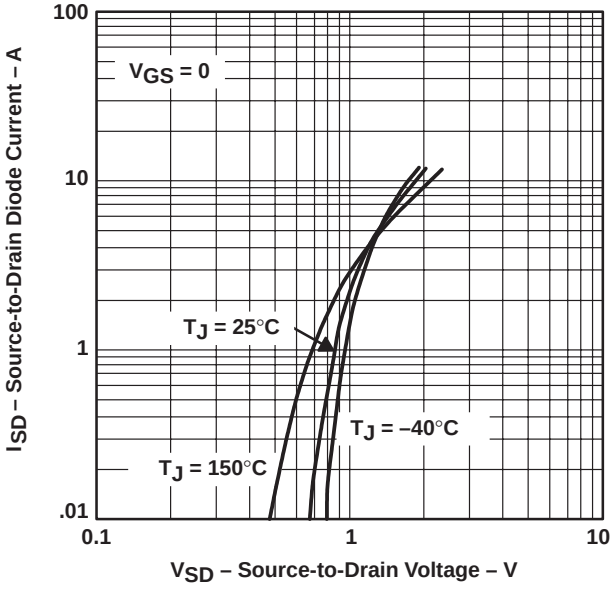


Figure 11

DRAIN-TO-SOURCE VOLTAGE AND GATE-TO-SOURCE VOLTAGE vs GATE CHARGE

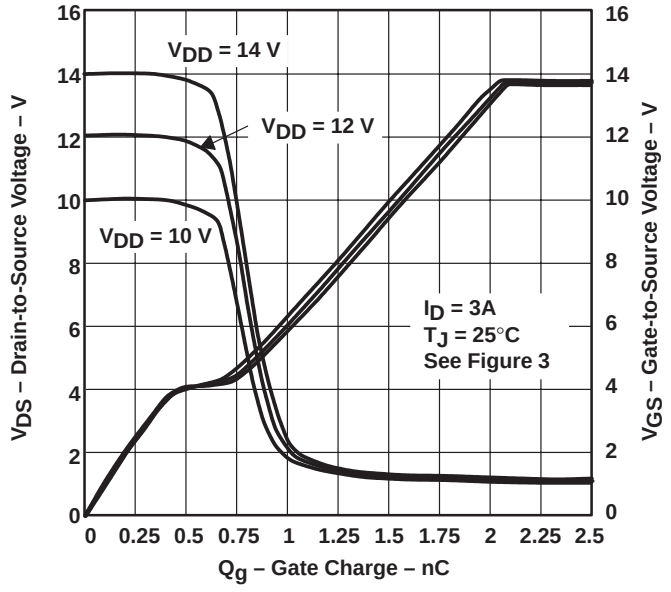


Figure 12

REVERSE RECOVERY TIME vs REVERSE di/dt

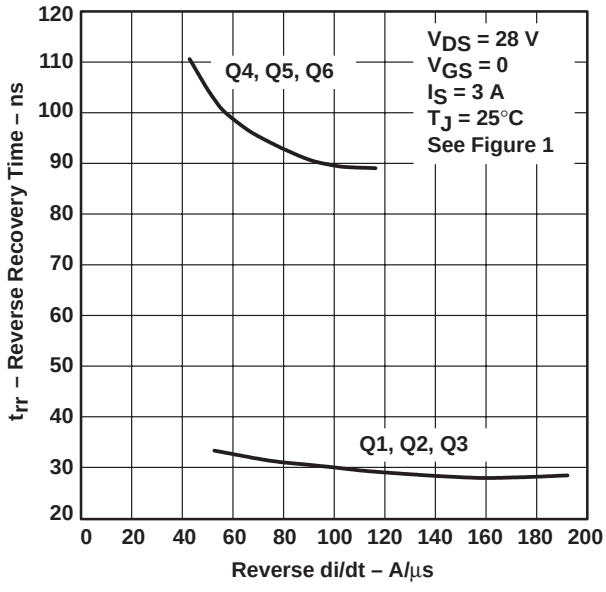
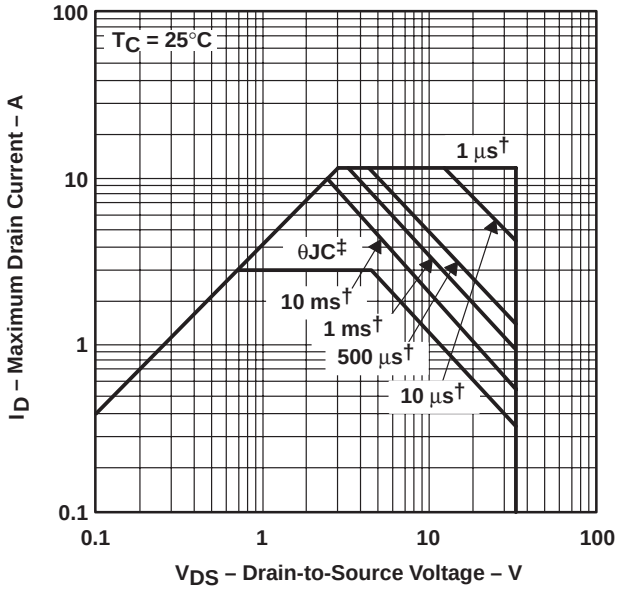


Figure 13

THERMAL INFORMATION

MAXIMUM DRAIN CURRENT
vs
DRAIN-TO-SOURCE VOLTAGE

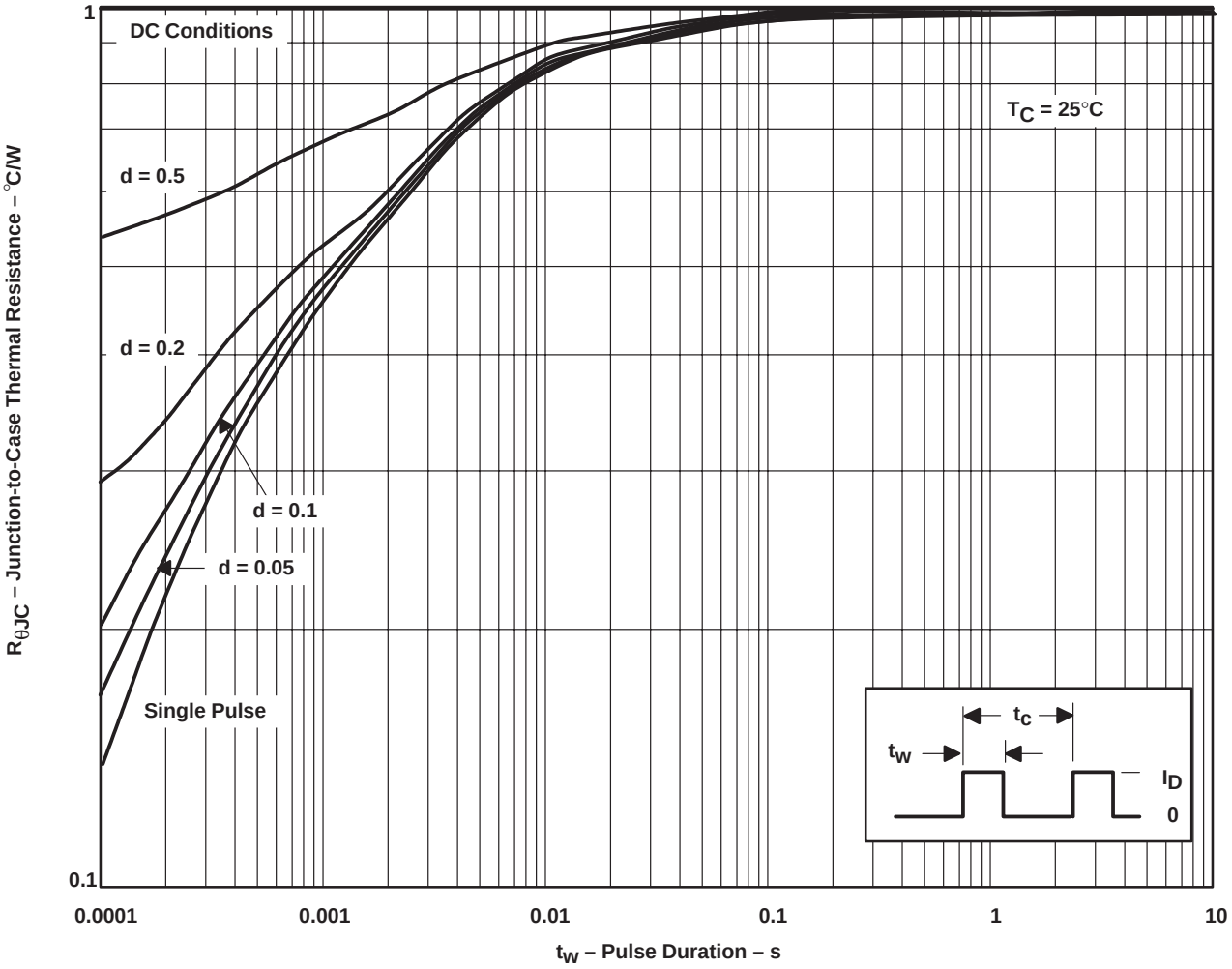


† Less than 2% duty cycle
‡ Device mounted in intimate contact with infinite heatsink.

Figure 14

THERMAL INFORMATION

**JUNCTION-TO-CASE THERMAL RESISTANCE
vs
PULSE DURATION**



† Package mounted in intimate contact with infinite heat sink.

NOTE E: $Z_{\theta JC}(t) = r(t)\ R_{\theta JC}$
t_W = pulse duration
t_C = cycle time
d = duty cycle = t_W / t_C

Figure 15

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
TPIC1310KTR	OBSOLETE	PFM	KTR	15		TBD	Call TI	Call TI
TPIC1310KTS	OBSOLETE	PFM	KTS	15		TBD	Call TI	Call TI

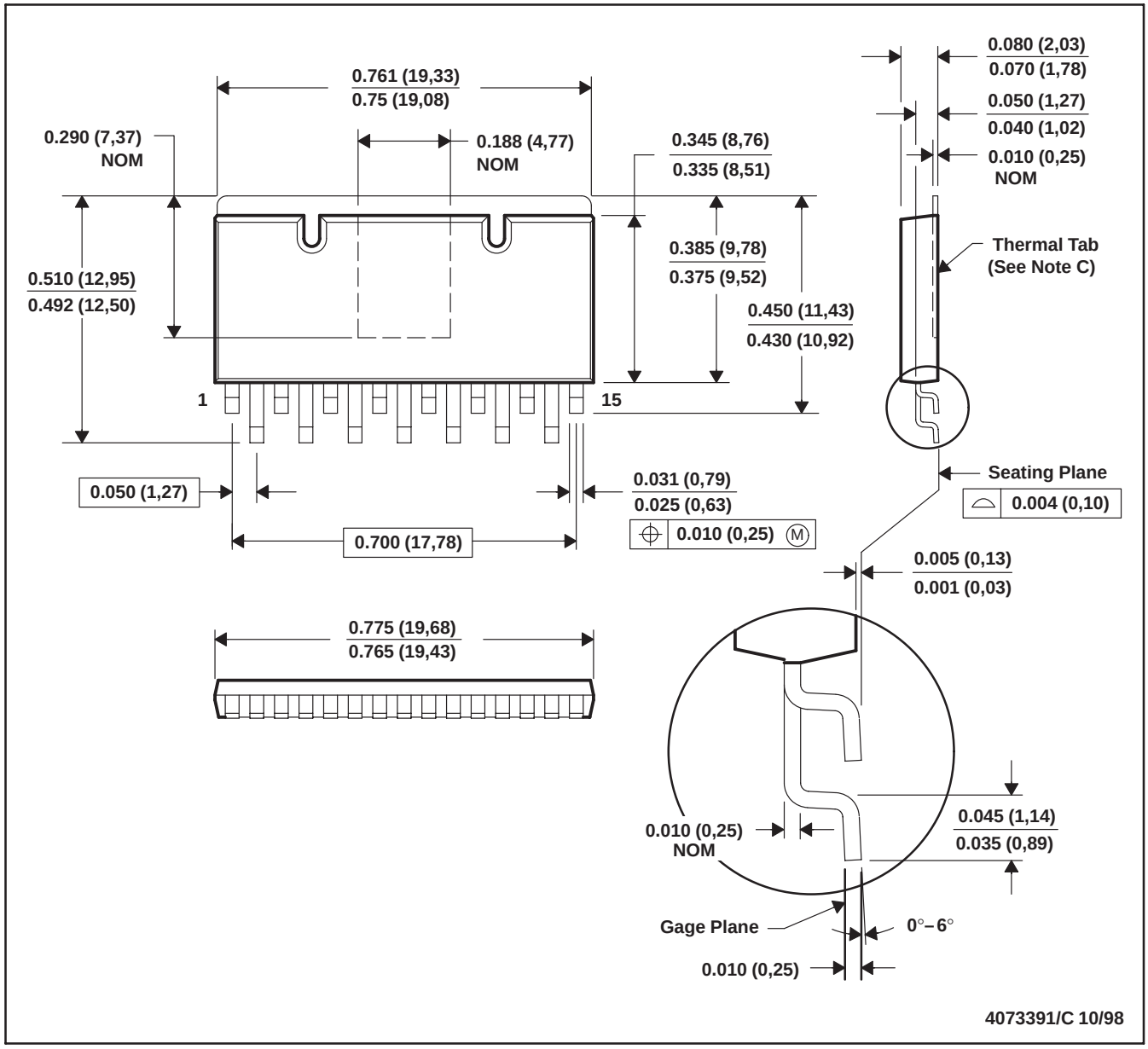
(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

MPSF004B – JANUARY 1997 – REVISED OCTOBER 1998

KTR (R-PSFM-G15) **PowerFLEX™ PLASTIC FLANGE-MOUNT**



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. The heatsink area is approximately 78K sq mils.
D. Dimensions do not include mold protrusions, not to exceed 0.006 (0,15).

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